

# Search Notes



Application/Control No.

10/625,682

Examiner

M. Lee

Applicant(s)/Patent under Reexamination

CHOI ET AL.

Art Unit

2622

## SEARCHED

Class	Subclass	Date	Examiner
348	730	3/29/2006	ML
	731	8/28/2006	ML
	725	12/18/06	ml
	726		
	553		
	554		
725	131		
	139		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference searched		12/18/06	ml

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	3/29/2006	ML
Updated	8/28/2006	ML
updated	12/18/06	ml